Search Notes						

Application/Control No.	Applicant(s)/Patent under Reexamination
10/531,521	KATAYAMA ET AL.
Examiner	Art Unit
Thanh X. Luu	2878

SEARCHED				
Class	Subclass	Date	Examiner	
250	223B	4/17/2006	TXL	
356	239.4	4/17/2006	TXL	
356	428	4/17/2006	TXL	
382	142	4/17/2006	TXL	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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	DATE	EXMR
see EAST text search notes	4/17/2006	TXL
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